Se	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/041,761	YOON ET AL.
Examiner	Art Unit
Hung Q. Dang	2621

SEARCHED				
Class	Subclass	Date	Examiner	
386	125.ccls.	12/9/2006	HQD .	
369	59.25	12/9/2006	HQD	
369	47.21	12/9/2006	HQD	
369	275.4	12/9/2006	HQD	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
STIC Plus Search	6/2/2006	HQD	
Inventors' Names Search	7/25/2006	HQD	
USPAT; US-PGPUB; USOCR; EPO: JPO: DERWENT; IBM_TDB (see Search History attached)	08/10/2006- 08/16/2006	HQD	
Consulted with Thai Tran	12/08/2006	HQD	
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